

S3012H

Single-Channel Precision Source Meter

Version 1.9



Product Description

The S3012H precision source meter is compact and cost-effective bench-top Source/Measure Units (SMUs) with the capability to source and measure both voltage and current. These capabilities make the S3012H ideal for a wide variety of IV (current versus voltage) measurement tasks that require both high resolution and accuracy.

The S3012H provides best-in-class performance for a modest price. They have broad voltage $(\pm 200 \text{ V})$ and current $(\pm 3 \text{ A DC} \text{ and } \pm 10 \text{ A pulsed})$ sourcing capability, excellent precision (minimum 100 fA/100 nV measuring resolution) and possess a superior color LCD graphical user interface (GUI). In addition, several task-based viewing modes dramatically improve productivity for test, debug, and characterization.

The S3012H offers unmatched measurement throughput and supports conventional SMU SCPI commands for easy test code migration. These features improve efficiency and lower the cost of ownership when integrating the SMUs into systems for production test.

Key Features

Feature	Benefit
Integrated 4-quadrant sourcing and measuring capabilities	Easily and accurately measure current and voltage using a single instrument without the need to manually change any connections
Measurement range: ± 200 V, ± 3 A (DC), ± 10 A (pulsed)	A single SMU product covers both high voltage and high current measurement needs, allowing for more standardization and simplifying inventory and support concerns
Source and measurement resolution down to 100 fA and 100 nV	Can make low-level measurements using a low-cost bench-top SMU that were previously only possible using a more expensive semiconductor device analyzer

Fast measurement	Up to 1M ADC sampling rate, NPLC and sampling rate optional setting		
User-friendly front panel GUI with 5.0 inch capacitive touchscreen supports both graphical and numerical view modes Free quick V/I control software	Can quickly and easily perform measurements and display data on the front panel, thereby greatly speeding up interactive test, characterization and debug operations Can make measurements remotely from a PC without the need to program		
Supports both conventional and default SCPI commands	Conventional SCPI commands provide some compatibility with older SMU code (such as Keithley 2400 series) to minimize code conversion work		
Synchronization	Highspeed/ low - delay multi-channel synchronization with hardware technology		
Digital I/O	Flexibly configured High-speed Digital I/O, support threshold value triggering, so as to realize efficient interaction between output measured values and user system		
Small form factor with USB2.0, LAN	Easy integration into rack and stack systems		

Applications

The S3012H has a broad application range that spans uses from R&D and education to industrial development, production test and automated manufacturing. Moreover, they work equally well as either standalone or system components.

Testing semiconductors, discrete and passive components

- Diodes, laser diodes, LEDs
- Photodetectors, sensors
- > Field effect transistors (FETs), bipolar junction transistors (BJTs)
- ➤ ICs (analog ICs, RFICs, MMICs, etc.)
- > Resistor, varistor, thermistors, switches

Testing precision electronics and green energy devices

- Photovoltaic cells
- > Power transistors, power devices
- Battery
- Automotive
- Medical instruments
- > Power and DC bias source for circuit test

Research and education

- New material investigations
- Nano devices characterization (e.g. CNT)
- > Giant magnetic resistance (GMR)
- Organic devices
- Any precise voltage/current source and measurement Specification

Technical Specification

Temperature:23 °C ± 5 °C

Humidity:30% to 70% RH

Calibration period:1 Year

Measurement speed: 1PLC (power line cycle)

After 60 minutes warm-up, ambient temperature changes less than \pm 3 $^{\circ}\text{C}$

Voltage source specifications

Voltage	Range	Programmin g resolution	Accuracy (1 Year) ± (% reading+ offset)	Typical Noise (RMS) 0.1 Hz-10 Hz	
	±200 V	1 mV	0.02%+30 mV	1.5 mV	
programming	±20 V	100 μV	0.02%+2 mV	160 μV	
accuracy	±6 V	50 μV	0.02%+500 μV	36 μV	
	±200 mV	1 μV	0.02%+120 μV	4 μV	
Temperature	± (0.15 ×)/05 (0.95 10.95 20.95 F0.95)				
coefficient	\pm (0.15 × accuracy)/°C (0°C-18°C,28°C-50°C)				
Maximum output	30W: +20V@1.5A +200V@0.1A: 18W: +6.V@3A				
power	30W: ±20V@1.5A, ±200V@0.1A; 18W: ±6 V@3A 				
Settling time	<800 μs (typical)				
Overshoot	$<\pm0.1\%$ (Typical. Norma mode. Step is 10 $\%$ to 90 $\%$ range, full range,				
Oversiloot	resistive load)				
Noise 10Hz-20MHz	6 V voltage source, 3 A resistive load, <3 mVrms				

Current source specifications

		D	A (1)/)	Typical	Noise
S	Range		Accuracy (1 Year)	(RMS)	
Current		resolution	± (% reading+ offset)	0.1 Hz-10 Hz	
programming	±10 A¹	50 μΑ	0.4% + 40 mA	NA	
accuracy	±3 A	15 μΑ	0.05%+2 mA	40 μΑ	
	±1.5 A	10 μΑ	0.02%+500 μΑ	20 μΑ	

		•	1			
	±150 mA	1 μΑ	0.02%+25 μΑ	5 μΑ		
	±15 mA	100 nA	0.02%+6 μΑ	700 nA		
	±1.5 mA	10 nA	0.02%+250 nA	16 nA		
	±150 μA	1 nA	0.02%+25 nA	1 nA		
	±15 μA	100 pA	0.02%+3 nA	140 pA		
	±1.5 μA	10 pA	0.03%+450 pA	25 pA		
	±150 nA	1 pA	0.05%+250 pA	5 pA		
Temperature	+(0.15 × ac	curacy)/°C (0°C	-18°C 28°C-50°C)			
coefficient	±(0.13 ∧ ac	\pm (0.15 × accuracy)/°C (0°C-18°C,28°C-50°C)				
Maximum output	2014. +2016	01 FA +200V@	0 14.19W: +6V@24			
power	30W: ±20V@1.5A, ±200V@0.1A;18W: ±6 V@3A					
Settling time	<500μs (typical)					
Overshoot	< $\pm 0.1\%$ (Typical. Normal mode. Step is 10 % to 90 % range, full range,					
Overshoot	resistive load					

^{1,10} A range is available only for pulse mode, accuracy specifications for 10 A range are typical.

Voltage measurement specifications

	Danga	Massurament recelution	Accuracy (1 Year) ± (% reading+
Voltage	Range	Measurement resolution	offset)
measurement	±200 V	100 μV	0.02% + 30 mV
accuracy	±20 V	10 μV	0.02% + 2 mV
	±6 V	1 μV	0.02% + 500 μV

	±200 mV	100 nV	0.02% + 120 μV				
Temperature	±(0.15 × a						
coefficient	(0.15 ∧ a	±(0.15 × accuracy)/°C (0°C-18°C,28°C-50°C)					

Current measurement specifications

	Range	Measurement resolution	Accuracy (1 Year) \pm (% reading+ offset)	
	±10 A¹	10 μΑ	0.4% + 25 mA	
	±3 A	10 μΑ	0.05%+2 mA	
Constant	±1.5A	1 μΑ	0.02%+500 μΑ	
Current	±150 mA	100 nA	0.02%+25 μΑ	
measurement	±15 mA	10 nA	0.02%+6 μΑ	
accuracy	±1.5 mA	1 nA	0.02%+250 nA	
	±150 μA	100 pA	0.02%+25 nA	
	±15 μA	10 pA	0.02%+3 nA	
	±1.5 μΑ²	1 pA	0.03%+450 pA	
	±150 nA ²	100 fA	0.05%+250 pA	
Temperature	$\pm (0.15 \times \text{accuracy})/^{\circ}\text{C} \ (0^{\circ}\text{C}-18^{\circ}\text{C},28^{\circ}\text{C}-50^{\circ}\text{C})$			
coefficient				

^{1, 10} A range is available only for pulse mode, accuracy specifications for 10 A range are typical.

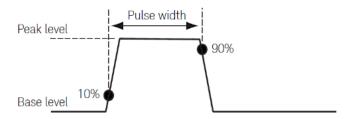
^{2,} Low Current Measurements, Triaxial Cable is recommended to connect: Force Hi connect to core cable, Guard connects to inner shield, outer shield connects to protective ground, Force Lo connect to core cable, inner shield not connect, and outer shield connect to protective ground. Triaxial Cable rated insulation voltage is not less than 250V.

Resistance measurement specifications (4W)

		Measuremen	Test	Typical accuracy (1 Year)	
ľ	Range	t resolution	current	± (% reading+ offset)	
	1 Ω	1 μΩ	1.5 A	0.073% +0.3334 mΩ	
	10 Ω	10 μΩ	150 mA	0.057% + 3.334 mΩ	
	100 Ω	100 μΩ	15 mA	0.08% + 33.34 mΩ	
	1 kΩ	1 mΩ	1.5 mA	0.057% + 333. 4 mΩ	
	10 kΩ	10 mΩ	150 μΑ	0.057% + 3.334 Ω	
	100 kΩ	100 mΩ	15 μΑ	0.06% + 33.34 Ω	
	1 ΜΩ	1 Ω	1.5 μΑ	0.06% + 333.4 Ω	
	10 ΜΩ	10 Ω	0.15 μΑ	0.35% + 3.334 kΩ	
	100 ΜΩ	100 Ω	0.05 μΑ	0.95% + 10 kΩ	
Temperature	+(0.15 × 2001/2001)/9C (0°C 10°C 20°C 50°C)				
coefficient	± (0.13 ×)	\pm (0.15 × accuracy)/°C (0°C-18°C,28°C-50°C)			
	Total error	= Vmeas/Isrc =	R reading x	(gain error % of V range + gain error %	
Source I mode,	of I range +	offset error of	I source ran	ge/Isrc value %) + (offset error of V	
manual Ohm	measure range/Isrc value)				
measurement	Example:I source value=1.5A at 1.5A range V measure range=6V range				
(4-wire)	Total error (% reading + offset) =(0.02%+0.02%+500μA/1.5A+(500μV/1.5A)				
		≈ 0.073%+0	.3334mΩ		

Pulse source specifications (4W)

Minimum programmable pulse width	100 μs
Pulse width programming resolution	1 μs
Pulse width programming accuracy	±10 μs
Pulse width jitter	2 μs
Dulas width deficition	The time from 10 % leading to 90 % trailing edge as
Pulse width definition	follows



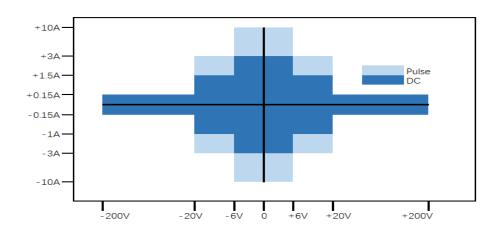
Item	Maximums	Maximum pulse width	Maximum duty cycle
1	0.15 A/200 V	DC, no limit	100%
2	1.5 A/20 V	DC, no limit	100%
3	3 A/6 V	DC, no limit	100%
4	3 A/20 V	1 ms	10%
5	10 A/6 V	1 ms	10%

Typical Pulse Performance(4W)

Source	range	Typical rise time ^{1,3}	Typical Settling Time ^{2,3}	Test load
	200 V	600 μs	1.5 ms	No load
Voltage	20 V	200 μs	360 μs	No load
	6 V	160 μs	300 μs	No load
	10 A	140 μs	320 μs	Full load
	3 A	120 μs	280 μs	Full load
Course	1.5 A	120 μs	280 μs	Full load
Current	150 mA	120 μs	280 μs	Full load
	15 mA	120 μs	280 μs	Full load
	1.5 mA	120 μs	280 μs	Full load

^{1,} Leading edge, the time from 10 % leading to 90 % leading

I-V Out capability



^{2,}The time required from Pulse out 0 to reach within 1% of final value

^{3,} Pulse current source base 6V voltage range and 105 % range limit

Typical output settling time

Saura Barra		Output settli	ng time		
Source	Range	Fast 1,2	Normal ¹	Slow 1	Condition
	200 V	<1.3 ms	<1.5 ms	<2.5 ms	Time required to reach within
Valtana	20 V	<300 μs	<360 μs	<1 ms	0.1 % of final value at open
Voltage	6 V	<150 μs	<250 μs	<1 ms	load condition. Step is 10 % to
	200 mV	<200 μs	<250 μs	<1 ms	90 % range
	3 A	<200 μs	<280 μs	<1.2 ms	
	1.5 A	<200 μs	<280 μs	<1.2 ms	Time required to reach within
	150 mA	<200 μs	<280 μs	<1.2 ms	0.1 % (0.3 % for 3 A range) of
	15 mA	<200 μs	<280 μs	<1.2 ms	final value at short condition.
Current	1.5 mA	<200 μs	<280 μs	<1.2 ms	Step is 10 % to 90 % range,
	150 μΑ	<250 μs	<300 μs	<1.2 ms	Pulse current source base 6V
	15 μΑ	<250 μs	<1.2 ms	<2 ms	voltage range and 105% range
	1.5 μΑ	<600 μs	<1.2 ms	<5 ms	limit
	150 nA	<600 μs	<5 ms	<12 ms	

^{1,} Output transition speed: Fast, Normal, Slow。

Sampling rate and NPLC setting

Setting	Range
NPLC	0.00005 PLC ~ 10 PLC

^{2,} Slow mode is recommended for overshoot sensitive equipment, Fast mode may have overshoot on output in some condition

Sampling Rate	5 sps ~ 1 Msps

Derating accuracy with PLC setting< 1 PLC

Add % of range using the following table for measurement with PLC < 1 $\,$

	Range									
PLC	PLC 200 mV	200 mV 6 V	20 V to	150 nA to	15 μΑ	150 μΑ	1.5 mA to	1.5 A to		
			200 V	1.5 μΑ			150 mA	3 A		
0.1	0.02%	0.01%	0.01%	0.02%	0.01%	0.01%	0.01%	0.01%		
0.01	0.3%	0.02%	0.02%	0.2%	0.04%	0.02%	0.02%	0.02%		
0.001	2.9%	0.35%	0.36%	1%	0.4%	2.9%	1.7%	2.7%		

Supplemental characteristics

Sensing Modes	2-wire or 4-wire (Remote-sensing) connections	
Maximum sense lead	1 kΩ for rated accuracy	
resistance:		
2W internal voltage drop	<60 mV/A	
Max voltage between Force	2 V	
and Sense		
Maximum output voltage in	>range 105% (200V range>202V)	
output connector		
DC floating voltage	Max ±250 V DC between low force and chassis ground	
Sweep	Sweep step time: from 20 μs to 16 s, Max: 64K point	
Auto range	Support, turn off output is recommended for overshoot	
Autoralige	sensitive equipment before range change	

Source delay	Support, It is recommended that users set appropriate source
Source delay	delay to obtain higher accuracy
	The output will be turned off (also disable operation) when the
Over temperature protection	SMU internal temperature is detected higher than 85 degrees.
Over temperature protection	When the temperature returns to less than 65 degrees, operation
	recover
	Turn off output when output voltage great than OVP setting
Over voltage protection	value, recover operation after power reset,
	Accuracy: ±(1%Setting+500mV)
Other abnormal protection	Power reset, recover operation or hardware damage

WARNING: here are potentially hazardous voltages ($\pm 210\,\text{V}$) present at the High Force, High Sense, and Guard terminals of this instrument. To prevent electrical shock, the safety precaution must be done before turn on the instrument. Never connect the Guard terminal to any output, including chassis ground, or output LO, doing so will damage the instrument

Communication port

LAN		100BASE-T / 10BASE-T
USB		USB 2.0 HOST (front)
USB		USB 2.0 DEVICE (back)
Digital I/O DB9	Pin5	GND
MAX input voltage: 5.25 V	Pin6	IO1, Digital I/O, Synchronous signal input

Min input voltage: -0.25 V		
Min logic H input voltage: 2.1		
v		
Max logic L input voltage: 0.7	Pin7	IO2, Digital I/O, Synchronous signal output
v		
Max source current: 2 mA		
Max sink current: -50 mA		

Environmental specifications

Environment	For use in indoor facilities
Operating	0 °C to +50 °C, 30 % to 70 % non-condensing
Storage	-30 °C to 70 °C, 10 % to 90 % non-condensing
Altitude	Operating: 0 m to 2000 m, Storage: 0 m to 4600 m
Power	LINE: 100-240 VAC, 50/60 Hz, 250 W; FUSE: T3.15AL 250 VAC
Warm-up	1 hour
Dimensions (mm)	$450 \times 212 \times 105$ (with foot pad/handle/ rotary Knob)
Weight	Net weight 5.2 kg

Compliance

C.F.	LVD Directive 2014/35/EU, Standards: EN 61010-1:2010+A1:2019
CE	EMC Directive 2014/30/EU, Standards: EN IEC 61326-1:2021

Front Panel

Display	5.0" TFT color display (800x480), Capacitive touchscreen
Hardkeys	Trigger, Home, Cancel, power on, output on/off, rotary Knob
Softkeys	LCD Mapping function keys
Connectivity	USB Host, output, ground

Rear panel

Connectivity	LAN, DB9, USB device, AC socket, Ground
--------------	-----------------------------------------

Ordering information

Power cable, USB cable, quick reference, U disk (including PDF manuals, quick I/V Measurement

Software and drivers)

Model number	
S3012H	Single Channel Precision Source Meter, pulser

Contact us

Mail

sales@semight.com

Address

No. 1508, Xiangjiang Road, Suzhou New District (SND), Jiangsu, China

Web

Visit www.semight.com for more information.

 * This information is subject to change without notice.